New Product



SiB408DK

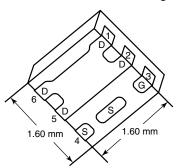
RoHS

FREE

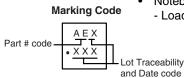
Vishay Siliconix

N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R_{DS(on)} (Ω)	I _D (A)	Q _g (Typ.)		
30	0.040 at V _{GS} = 10 V	7 ^a	2.9 nC		
	0.050 at V _{GS} = 4.5 V	7 ^a	2.9110		



PowerPAK SC-75-6L-Single

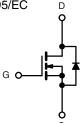


FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET
- New Thermally Enhanced PowerPAK[®] SC-75 Package
 - Small Footprint Area
- Low On-Resistance
- 100 % R_g Tested
- 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

Notebook
 Load Switch



Ordering Information: SiB408DK-T1-GE3 (Lead (Pb)-free and Halogen-free)

N-Channel MOSFET

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	30	v	
Gate-Source Voltage	V _{GS}	± 20	v	
Continuous Drain Current (T _J = 150 °C)	$T_{C} = 25 °C$ $T_{C} = 70 °C$ $T_{A} = 25 °C$ $T_{A} = 70 °C$	I _D	7 ^a 7 ^a 6 ^{b, c} 4.8 ^{b, c}	
Pulsed Drain Current		I _{DM}	20	— A
Continuous Source-Drain Diode Current	T _C = 25 °C T _A = 25 °C	I _S	7 ^a 2 ^{b, c}	_
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	10	
Avalanche Energy	L = 0.1 mm	E _{AS}	5	mJ
Maximum Power Dissipation	$T_{C} = 25 \text{ °C}$ $T_{C} = 70 \text{ °C}$ $T_{A} = 25 \text{ °C}$ $T_{A} = 70 \text{ °C}$	P _D	13 8.4 2.4 ^{b, c} 1.6 ^{b, c}	w
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature		260		

THERMAL RESISTANCE RATINGS Maximum Parameter Symbol Typical Unit Maximum Junction-to-Ambient^{b, f} $t \le 5 s$ R_{th,JA} 41 51 °C/W Maximum Junction-to-Case (Drain) Steady State R_{thJC} 7.5 9.5

Notes:

a. Package limited.

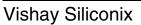
b. Surface Mounted on 1" x 1" FR4 board.

c. t = 5 s.

e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under Steady State conditions is 105 °C/W.

d. See Solder Profile (<u>www.vishay.com/ppg273257</u>). The PowerPAK SC-75 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.





SPECIFICATIONS T _J = 25 °C, unless otherwise noted										
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit				
Static				1	1					
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_D = 250 \mu A$	30			V				
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		29		mV/°C				
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			- 5.2						
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	1.2		2.5	V				
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA				
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 55 \text{ °C}$			1 10	μA				
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	20			Α				
	2 (011)	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 6 \text{ A}$		0.032	0.040	Ω				
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 5 \text{ A}$		0.040	0.050					
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 15 \text{ V}, \text{ I}_{D} = 6 \text{ A}$		14	0.000	S				
Dynamic ^b										
Input Capacitance	C _{iss}			350						
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		65		pF				
Reverse Transfer Capacitance	C _{rss}			28						
·		V _{DS} = 15 V, V _{GS} = 4.5 V, I _D = 6 A		2.9	4.4					
Total Gate Charge	Qg			6.2	9.5	nC				
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 6 \text{ A}$		1.0						
Gate-Drain Charge	Q _{gd}			0.85						
Gate Resistance	R _g	f = 1 MHz	0.5	2.5	5	Ω				
Turn-On Delay Time	t _{d(on)}			13	20	- ns				
Rise Time	t _r	V_{DD} = 15 V, R_L = 15 Ω		11	17					
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 1.0 \text{ A}, \text{ V}_{\text{GEN}} = 4.5 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		11	17					
Fall Time	t _f	, i i i i i i i i i i i i i i i i i i i		9	15					
Turn-On Delay Time	t _{d(on)}			5	10					
Rise Time	t _r	$V_{DD} = 15 \text{ V}, \text{ R}_{1} = 15 \Omega$		8	15	- ns				
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 1.0 \text{ A}, \text{ V}_{\text{GEN}} = 10 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		13	20					
Fall Time	t _f	_		6	12					
Drain-Source Body Diode Characterist	11				n	<u> </u>				
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C		1	7					
Pulse Diode Forward Current	I _{SM}	-			20	A				
Body Diode Voltage	V _{SD}	I _S = 2.0 A, V _{GS} = 0 V		0.8	1.2	V				
Body Diode Reverse Recovery Time	t _{rr}			13	26	ns				
Body Diode Reverse Recovery Charge	Q _{rr}	- I _F = 2.0 A, dl/dt = 100 A/μs, T _J = 25 °C		7	14	nC				
Reverse Recovery Fall Time	t _a			9	-	- ns				
Reverse Recovery Rise Time	t _b			4						

Notes:

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

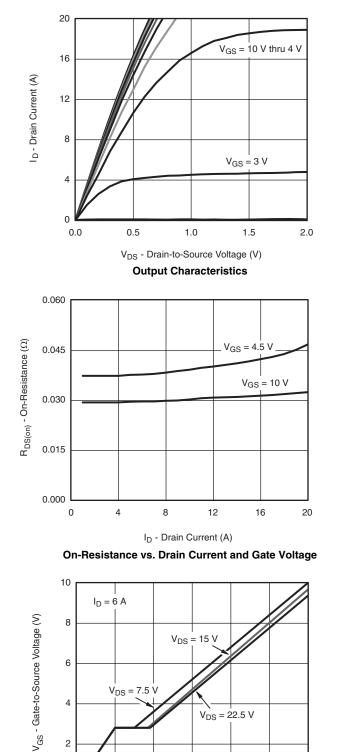
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SiB408DK

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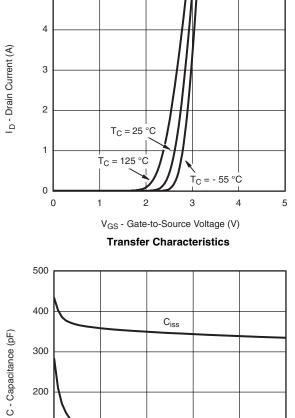


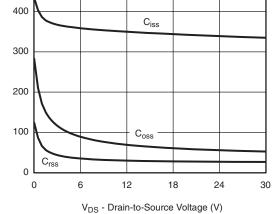
V_{DS} = 22.5 V

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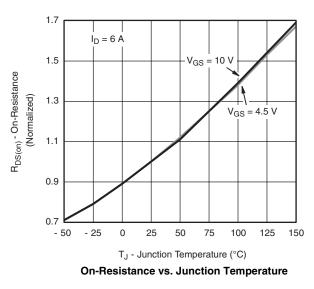
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4

2

0

0

1

2

3

Q_q - Total Gate Charge (nC)

Gate Charge

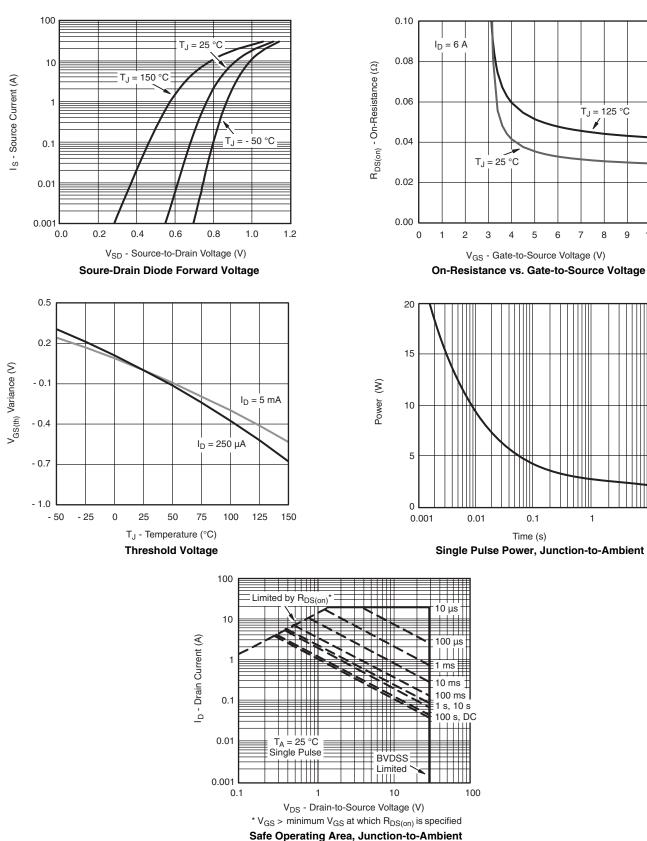
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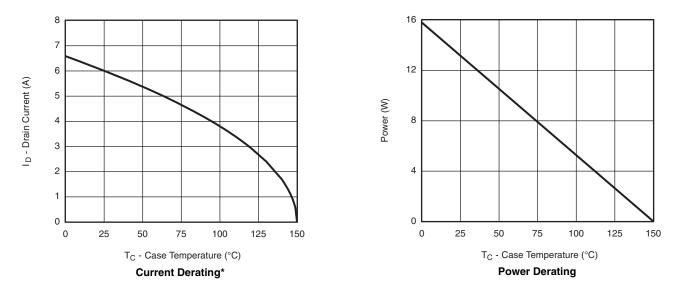
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





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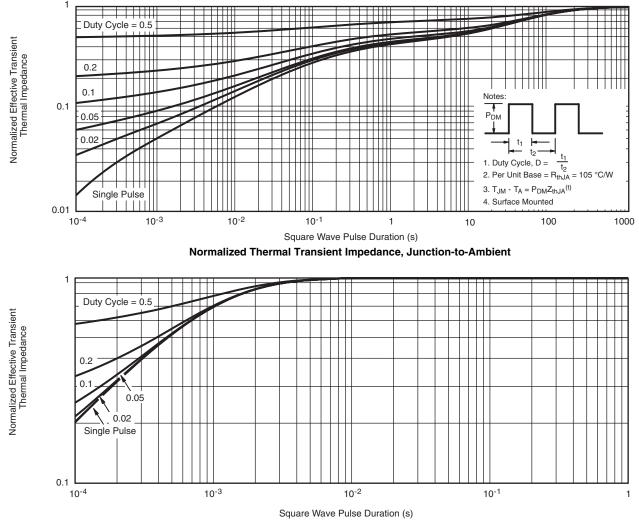


* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg264828.



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